TOSHIBA Field Effect Transistor Silicon P Channel MOS Type

SSM3J02T

Power Management Switch High Speed Switching Applications

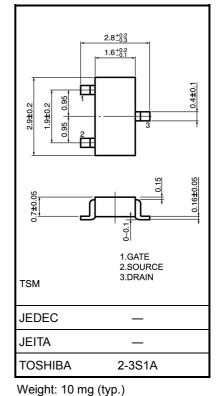
- Component package suitable for high-density mounting
- Small Package
- Low ON Resistance : $R_{on} = 0.5 \Omega (max) (@V_{GS} = -4 V)$

 $: R_{on} = 0.7 \Omega (max) (@V_{GS} = -2.5 V)$

Low-voltage operation possible

Maximum Ratings (Ta = 25°C)

Characteristic		Symbol	Rating	Unit	
Drain-Source voltage		V _{DS}	-30	V	
Gate-Source voltage		V _{GSS}	±10	V	
Drain current	DC	I _D	-1.5	А	
	Pulse	I _{DP} (Note2)	-3.0		
Drain power dissipation (Ta = 25° C)		P _D (Note1)	1250	mW	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	–55 to 150	°C	



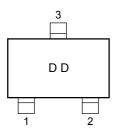
Note1: Mounted on FR4 board

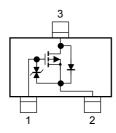
 $(25.4 \text{ mm} \times 25.4 \text{ mm} \times 1.6 \text{ t}, \text{ Cu pad: } 645 \text{ mm2}, \text{ t} = 10 \text{ s})$

Note2: The pulse width limited by max channel temperature.

Marking

Equivalent Circuit





Handling Precaution

When handling individual devices (which are not yet mounted on a circuit board), be sure that the environment is protected against electrostatic electricity. Operators should wear anti-static clothing, and containers and other objects that come into direct contact with devices should be made of anti-static materials.

Unit: mm

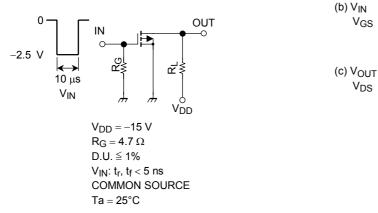
Electrical Characteristics (Ta = 25°C)

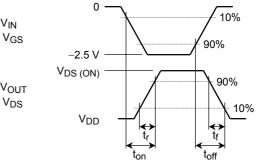
Characteristic		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS}=\pm 10~V,~V_{DS}=0$	_		±1	μA
Drain-Source breakdown voltage		V (BR) DSS	$I_{D} = -1 \text{ mA}, V_{GS} = 0$	-30			V
Drain Cut-off current		I _{DSS}	$V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0$	_	_	-1	μA
Gate threshold voltage		V _{th}	$V_{DS} = -3 \text{ V}, \text{ I}_{D} = -0.1 \text{ mA}$	-0.6		-1.1	V
Forward transfer admittance		Y _{fs}	$V_{DS} = -3 V, I_D = -0.3 A$ (Note3)	0.6			S
Drain-Source ON resistance		R _{DS (ON)}	$I_D = -0.3 \text{ A}, V_{GS} = -4 \text{ V}$ (Note3)	_	0.4	0.5	Ω
			$I_D = -0.3 \text{ A}, V_{GS} = -2.5 \text{ V}$ (Note3)	_	0.55	0.7	
Input capacitance		C _{iss}	$V_{DS} = -10 \text{ V}, \text{ V}_{GS} = 0, \text{ f} = 1 \text{ MHz}$	_	150		pF
Reverse transfer capacitance		C _{rss}	$V_{DS} = -10 \text{ V}, \text{ V}_{GS} = 0, \text{ f} = 1 \text{ MHz}$	_	21		pF
Output capacitance		C _{oss}	$V_{DS} = -10 \text{ V}, \text{ V}_{GS} = 0, \text{ f} = 1 \text{ MHz}$	_	61		pF
Switching time	Turn-on time	t _{on}	V _{DD} = -15 V, I _D = -0.3 A,	_	55		ns
	Turn-off time	t _{off}	$V_{GS} = 0$ to -2.5 V, $R_{G} = 4.7 \Omega$	_	52		

Note3: Pulse test

Switching Time Test Circuit

(a) Test circuit





Precaution

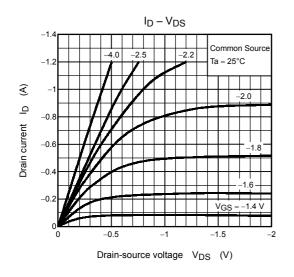
 V_{th} can be expressed as voltage between gate and source when low operating current value is ID = $-100~\mu A$ for this product. For normal switching operation, V_{GS} (on) requires higher voltage than V_{th} and V_{GS} (off) requires lower voltage than V_{th} .

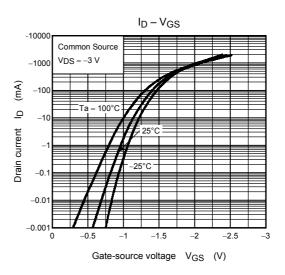
(relationship can be established as follows: VGS (off) < Vth < VGS (on))

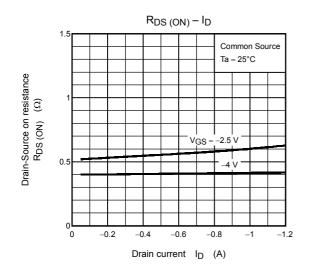
Please take this into consideration for using the device.

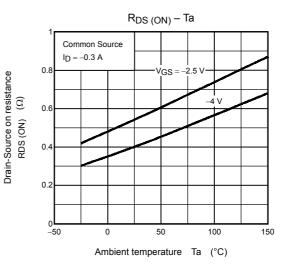
 $\rm VGS$ recommended voltage of –2.5 V or higher to turn on this product.

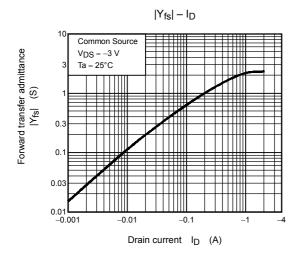
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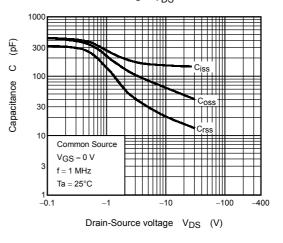




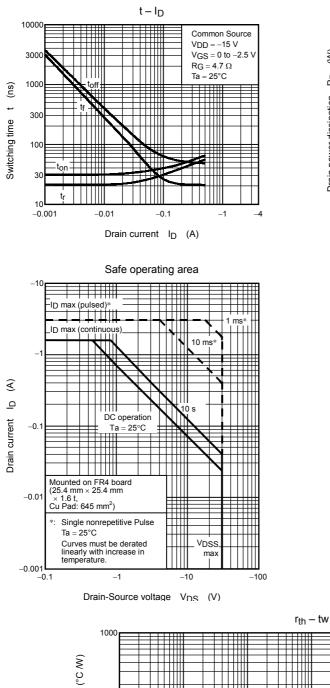


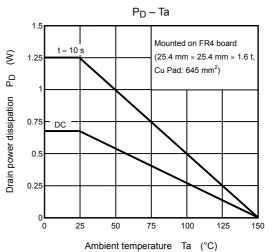


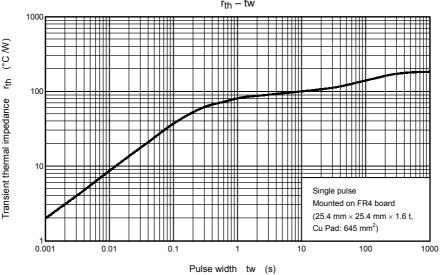
 $C - V_{DS}$



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